Notice of References Cited Examiner Art Unit

10/589,681 OGATA ET AL.

Applicant(s)/Patent Under Reexamination

Page 1 of 1

JOHN S. CHU 1795

U.S. PATENT DOCUMENTS

Application/Control No.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0148594 A1	06-2007	Funatsu et al.	430/270.1
*	В	US-2006/0160247 A1	07-2006	Koyama et al.	438/001
*	υ	US-2003/0224289 A1	12-2003	Choi et al.	430/270.1
*	D	US-7,402,712 B2	07-2008	Hatakeyama et al.	568/665
*	Е	US-7,189,493 B2	03-2007	Hatakeyama et al.	430/270.1
	F	US-			
	O	US-		-	
	Ξ	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N							
	0							
	Р							
	Q							
	R							
	s							
	т							

NON-PATENT DOCUMENTS

HON ALEN DOGMENTO								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	v							
	w							
	x							

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.